

NOT RECOMMENDED FOR NEW DESIGNS

PN Unijunction Transistors Silicon Plastic Unijunction Transistors

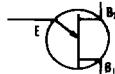
... designed for military and industrial use in pulse, timing, triggering, sensing, and oscillator circuits. The annular process provides low leakage current, fast switching and low peak-point currents as well as outstanding reliability and uniformity.

Recommended usage includes:

- Long-time Delay Circuits — MU4894
- Silicon Controlled Rectifier Triggering Circuits — MU4893
- High-frequency Relaxation-Oscillator Circuits — MU4892
- General-Purpose Unijunction Applications — MU4891

**MU4891
thru
MU4894**

PN UJTs



MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

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Rating	Symbol	Value	Unit
RMS Power Dissipation, Note 1	P_D	300	mW
RMS Emitter Current	I_E	50	mA
Peak Pulse Emitter Current, Note 2	I_E	1	Amp
Emitter Reverse Voltage	V_{B2E}	30	Volts
Storage Temperature Range	T_{stg}	-65 to +150	°C

Notes: 1. Derate 3 mW/°C increase in ambient temperature. Total power dissipation (available power to Emitter and Base Two) must be limited by external circuitry. Interbase voltage (V_{B2B1}) limited by power dissipation,

$$V_{B2B1} = \sqrt{R_{BB} \cdot P_D}$$

2. Capacitance discharge current must fall to 0.37 Amp within 3 ms and PRR ~ 10 PPS.

MU4891 thru MU4894

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
Intrinsic Standoff Ratio ($V_{B2B1} = 10 \text{ V}$), Note 1	η	0.51	—	0.69	—
MU4892		0.55	—	0.82	—
MU4891, MU4893		0.74	—	0.86	—
MU4894					
Interbase Resistance ($V_{B2B1} = 3 \text{ V}$, $I_E = 0$)	R_{BB}	4	7	9.1	k ohms
MU4891, MU4892		4	7	12	
MU4893, MU4894					
Interbase Resistance Temperature Coefficient ($V_{B2B1} = 3 \text{ V}$, $I_E = 0$, $T_A = -65^\circ\text{C}$ to $+100^\circ\text{C}$)	αR_{BB}	0.1	—	0.9	%/ $^\circ\text{C}$
Emitter Saturation Voltage ($V_{B2B1} = 10 \text{ V}$, $I_E = 50 \text{ mA}$), Note 2	$V_{EB1(\text{sat})}$	—	2.5	4	Volts
Modulated Interbase Current ($V_{B2B1} = 10 \text{ V}$, $I_E = 50 \text{ mA}$)	$I_{B2(\text{mod})}$	10	15	—	mA
Emitter Reverse Current ($V_{B2E} = 30 \text{ V}$, $I_B1 = 0$)	I_{EB2O}	—	5	10	nA
Peak Point Emitter Current ($V_{B2B1} = 25 \text{ V}$)	I_P	—	0.6	5	μA
MU4891		—	0.6	2	
MU4892, MU4893		—	0.6	1	
MU4894					
Valley Point Current ($V_{B2B1} = 20 \text{ V}$, $R_{B2} = 100 \text{ Ohms}$), Note 2	I_V	—	—	—	mA
MU4891, MU4893, MU4894		2	4	—	
MU4892		2	3	—	
Base-One Peak Pulse Voltage (Note 3, Figure 3)	V_{OB1}	3	5	—	Volts
MU4891, MU4892, MU4894		6	8	—	
MU4893					

Notes:

1. Intrinsic standoff ratio.

η , is defined by equation:

$$\eta = \frac{V_P - V_{(EB1)}}{V_{B2B1}}$$

Where V_P = Peak Point Emitter Voltage

V_{B2B1} = Interbase Voltage

$V_{(EB1)}$ = Emitter to Base-One Junction Diode Drop
(0.5 V to $10 \mu\text{A}$)

2. Use pulse techniques: $PW = 300 \mu\text{s}$, duty cycle $< 2\%$ to avoid internal heating due to interbase modulation which may result in erroneous readings.

3. Base-One Peak Pulse Voltage is measured in circuit of Figure 3. This specification is used to ensure minimum pulse amplitude for applications in SCR firing circuits and other types of pulse circuits.

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FIGURE 1 — UNIJUNCTION TRANSISTOR SYMBOL AND NOMENCLATURE

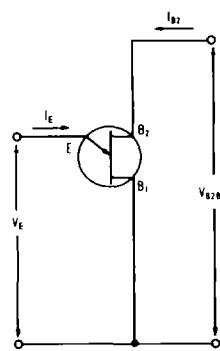


FIGURE 2 — STATIC Emitter CHARACTERISTICS CURVES

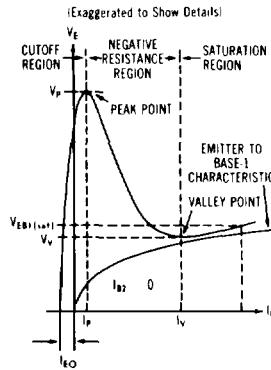


FIGURE 3 — V_{OB1} TEST CIRCUIT
(Typical Relaxation Oscillator)

